

**Name** **Mr. Prasanna V. Sathe**

Designation Deputy Registrar - Examination  
Department Examination  
Date of Joining the Institute 01-07-2008  
Education M.Sc. First Class (UOM), B.Ed. – Second (UOM)  
Branch / Specialization (PHYSICS (ELECTRONICS: MICROPROCESSOR AND MICROCOMPUTER))  
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## Work Experience

Name of the University / Institute/ Industry	Duration	Designation
Gogate Jogalekar College, Ratnagiri	June 2001- May 2002	Lecturer in physics for under-graduate level
Abhyankar- Kulkarni Jr. College, Ratnagiri	June 2002 to May 2004	Teacher in Information Technology for Junior college
Abhyankar- Kulkarni Jr. College, Ratnagiri	June 2004 to May 2006	Teacher in Physics for Junior college
Gogate Jogalekar College, Ratnagiri	June 2006- May 2008	Lecturer in Computer Science for under graduate
Finolex Academy of Management of Technology, Ratnagiri	01 July 2008 – 31 Dec 2012	Lecturer in Applied physics
Finolex Academy of Management of Technology, Ratnagiri	01 Jan 2013 – 31 July 2020	Deputy Registrar- Academics

**Total Experience – 24 Years**

**PUBLICATIONS**

1. Paper on “Design of PC based titration monitoring system” presented at International Conference (INCON-2004) organized by Instrumentation society of India and Department of Instrumentation and control, Pune Institute of Engineering and Technology, Pune, from 19<sup>th</sup> December 2004 to 21<sup>st</sup> December 2004.
2. Paper on “Design of PC based temperature control unit for laboratory type furnaces” presented at International conference on Instrumentation (INCON-2004) organized by Instrumentation society of India and Department of Instrumentation and control, Pune Institute of Engineering and Technology, Pune from 19<sup>th</sup> December 2004 to 21<sup>st</sup> December 2004.
3. Paper on “Design of Microprocessor based sensor-less, intelligent traffic-light control system to reduce waiting time at the signals” presented at National Symposium on Instrumentation (NSI-30) organized by Instrumentation society of India and Department of Instrumentation and sophisticated Test and Instrumentation centre, University of Science and Technology, Cochin from 30<sup>th</sup> November 2005 to 2<sup>nd</sup> December 2005.